	 rch Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/502,468	SHOUJI, MICHIHIKO	
Examiner	Art Unit	
 Michelle K. Lay	2672	

SEARCHED			
Class	Subclass	Date	Examiner
700	255	7/20/2005	MKL
. 463	32	7/20/2005	MKL
			-

INI	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
L			

SEARCH I (INCLUDING SEAR)
	DATE	EXMR
EAST search	7/20/2005	MKL
EAST search	8/10/2005	MKL
Consulted with Rich Hjerpe	7/20/2005	MKL